

Search Notes

Application/Control No.

10/660,621

Examiner

TAN Q. NGUYEN

Applicant(s)/Patent under
Reexamination

SAKAI ET AL.

Art Unit

3661

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search of 02/02/2005	9/30/2005	TN